

REVISIONS													
LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED										

REV													
SHEET													
REV													
SHEET													
REV STATUS OF SHEETS	REV												
	SHEET	1	2	3	4	5	6	7	8	9	10	11	

PMIC N/A STANDARDIZED MILITARY DRAWING THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE AMSC N/A	PREPARED BY <i>Rick Offin</i> CHECKED BY <i>Charles Rensing</i> APPROVED BY <i>[Signature]</i> DRAWING APPROVAL DATE 31 OCTOBER 1989 REVISION LEVEL	DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444 MICROCIRCUIT, LINEAR, OVERVOLTAGE SENSING CIRCUIT, MONOLITHIC SILICON <table style="width:100%;"> <tr> <td style="width: 15%;">SIZE</td> <td style="width: 35%;">CAGE CODE</td> <td style="width: 50%;"></td> </tr> <tr> <td style="text-align: center;">A</td> <td style="text-align: center;">67268</td> <td style="text-align: center;">5962-89780</td> </tr> </table>	SIZE	CAGE CODE		A	67268	5962-89780
SIZE	CAGE CODE							
A	67268	5962-89780						
		SHEET 1 OF 11						

DESC FORM 193
SEP 87

U.S. GOVERNMENT PRINTING OFFICE: 1987 - 748-129/60911

5962-E1486

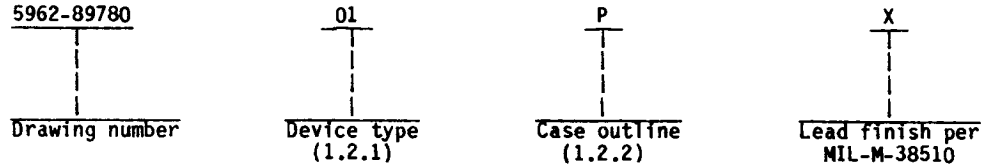
DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

查询"5962-8978001PA"供应商

1. SCOPE

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:



1.2.1 Device type. The device type shall identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>Circuit function</u>
01	3523	Overvoltage sensing circuit

1.2.2 Case outline. The case outline shall be as designated in appendix C of MIL-M-38510, and as follows:

<u>Outline letter</u>	<u>Case outline</u>
P	D-4 (8-lead, .405" x .310" x .200"), dual-in-line package

1.3 Absolute maximum ratings.

Differential power supply voltage ($V^+ - V^-$)	-----	40 V dc
Voltage at sense 1 (S1)	-----	6.5 V dc
Voltage at sense 2 (S2)	-----	6.5 V dc
Storage temperature range	-----	-65°C to +150°C
Maximum power dissipation (P_D)	-----	500 mW
Lead temperature (soldering, 10 seconds)	-----	+300°C
Thermal resistance, junction-to-case (θ_{JC})	-----	See MIL-M-38510, appendix C
Thermal resistance, junction-to-ambient (θ_{JA})	-----	150°C/W
Junction temperature (T_J)	-----	+175°C
Output current (I_O)	-----	300 mA
Remote activation input voltage	-----	7.0 V

1.4 Recommended operating conditions.

Supply voltage ($V^+ - V^-$)	-----	5.0 V dc to 36 V dc
Ambient operating temperature range (T_A)	-----	-55°C to +125°C

STANDARDIZED MILITARY DRAWING <small>DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444</small>	SIZE A	5962-89780
	REVISION LEVEL	SHEET 2

2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103 - List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.

3.2.2 Logic diagram. The logic diagram shall be as specified on figure 2.

3.2.3 Case outline. The case outline shall be in accordance with 1.2.2 herein.

3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full ambient operating temperature range.

3.4 Electrical test requirement. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.

3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A		5962-89780
		REVISION LEVEL	SHEET 3

TABLE I. Electrical performance characteristics.						
Test	Symbol	Conditions -55°C < T _A < +125°C unless otherwise specified	Group A subgroups	Limits		Unit
				Min	Max	
Supply current	I _{CC1}	V ⁺ - V ⁻ = +40 V S1, S2 = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3		25	mA
	I _{CC2}	V ⁺ - V ⁻ = +36 V S1, S2 = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3		7	mA
	I _{CC3}	V ⁺ - V ⁻ = +5 V S1, S2 = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3		7	mA
	I _{CC4}	V ⁺ - V ⁻ = +4.5 V S1, S2 = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3		7	mA
Voltage at sense 1 (S1)	V _{S1-5}	Measure threshold at pin 2 ramp pin 2 until pin 8 goes positive through 3.0 V Tie pin 3 to pin 4, (pin 6) <u>1</u> /, T _A = +25°C, V ⁺ - V ⁻ = 5 V	1	2.45	2.75	V
Voltage at sense 2 (S2)	V _{S2-5}	Measure threshold at pin 3 ramp pin 3 until pin 8 goes positive through 3.0 V RA = GND, (pin 6) <u>1</u> /, S1 = GND, (pin 8) <u>2</u> / (pin 4) <u>2</u> /, T _A = +25°C, V ⁺ - V ⁻ = 5 V	1	2.45	2.75	V
Voltage at sense 1 (S1)	V _{S1-36}	Measure threshold at pin 2 ramp pin 2 until pin 8 goes positive through 34 V Tie pin 3 to pin 4, RA = GND (pin 6) <u>1</u> /, (pin 8) <u>2</u> /, T _A = +25°C, V ⁺ - V ⁻ = 36 V	1	2.45	2.75	V
Voltage at sense 2 (S2)	V _{S2-36}	Measure threshold at pin 3 ramp pin 3 until pin 8 goes positive through 34 V S1 = GND, (pin 4) <u>2</u> /, RA = GND (pin 6) <u>1</u> /, (pin 8) <u>2</u> /, T _A = +25°C, V ⁺ - V ⁻ = 36 V	1	2.45	2.75	V
See footnotes at end of table.						
STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444			SIZE A	5962-89780		SHEET 4
			REVISION LEVEL			

TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C < T _A < +125°C unless otherwise specified	Group A subgroups	Limits		Unit
				Min	Max	
Output voltage high	V _{OH}	Measure voltage at pin 8 S1, S2 = 3 V, RA = GND, (pin 6) 2/ I _{OH} = 100 mA to GND V ⁺ - V ⁻ = 5 V	1, 2, 3	2.8		V
Output voltage low	V _{OL}	Measure voltage from pin 8 to pin 1, S1, S2 = 3 V, RA = GND, (pin 6) 2/ I _{OH} = 100 mA to GND V ⁺ - V ⁻ = 36 V	1, 2, 3		2.2	V
Indicator voltage	V _{IA}	Measure voltage at pin 6 S1, S2 = 3 V, RA = GND, I _{OHA} = 1.6 mA to pin 6 V ⁺ - V ⁻ = 5 V	1, 2, 3		0.4	V
Indicator voltage	V _{IB}	Measure voltage at pin 6 S1, S2 = 3 V, RA = GND, I _{OHA} = 1.6 mA to pin 6 V ⁺ - V ⁻ = 36 V	1, 2, 3		0.4	V
Remote activation current	I _{R1}	Measure current out of pin 5 S1 = 3 V, S2 = GND, RA = 0.8 V (pin 6) 1/, (pin 8) 2/ V ⁺ - V ⁻ = 5 V	1, 2, 3		180	μA
Remote activation current	I _{R2}	Measure current into pin 5 S1 = 3 V, S2 = GND, RA = 2 V (pin 6) 1/, (pin 8) 2/ V ⁺ - V ⁻ = 5 V	1, 2, 3		40	μA
Remote activation voltage	V _{R2A}	Measure voltage at pin 8 V ⁺ - V ⁻ = 5 V, S1 = 3 V, S2 = GND, RA = 0.8 V (pin 6) 1/, (pin 8) 2/	1, 2, 3		0.5	V
Remote activation voltage	V _{R2B}	Measure voltage at pin 8 V ⁺ - V ⁻ = 5 V, S1 = 3 V, S2 = GND, RA = 2.0 V, (pin 6) 1/, (pin 8) 2/	1, 2, 3	3.0		V

See footnotes at end of table.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780
	REVISION LEVEL	SHEET 5

TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C < T _A < +125°C unless otherwise specified	Group A subgroups	Limits		Unit
				Min	Max	
Source current	I _{4A}	Measure current out of pin 4 V ⁺ - V ⁻ = 36 V, S1 = 3 V, S2 = GND, CS = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3	100	300	μA
Source current	I _{4B}	Measure current out of pin 4 V ⁺ - V ⁻ = 5 V, S1 = 3 V, S2 = GND, CS = GND, RA = GND, (pin 6) <u>1</u> /	1, 2, 3	100	300	μA
Indicator leakage	I _{6L}	Measure current into pin 6 V ⁺ - V ⁻ = 36 V, S1 = GND, S2 = GND, CS = GND, RA = GND, (pin 6) <u>1</u> / (pin = 8) <u>2</u> /, T _A = +25°C	1		5.0	μA
Output leakage	I _{8L}	Measure current into pin 8 V ⁺ - V ⁻ = 36 V, S1 = GND, S2 = GND, CS = GND, RA = GND, (pin 6) <u>1</u> /, (pin 8) <u>2</u> /, T _A = +25°C	1		60	μA
Source voltage	V _{SA}	Measure voltage at pin 4 V ⁺ - V ⁻ = 36 V, S1 = GND, S2 = GND, CS = 1 mA, into pin 4, RA = GND, (pin 6) <u>1</u> / (pin 8) <u>2</u> /, T _A = +25°C	1		1.0	V
Source voltage	V _{SB}	Measure voltage at pin 4 V ⁺ - V ⁻ = 5 V, S1 = GND, S2 = GND, CS = 1 mA into pin 4, RA = GND, (pin 6) <u>1</u> / (pin 8) <u>2</u> /, T _A = +25°C	1		1.0	V

1/ 10 kΩ to pin 1.
2/ 10 kΩ to GND.

3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780
	REVISION LEVEL	SHEET 6

Device type	01
Case outline	P
Terminal number	Terminal symbol
1	V+
2	Sense 1, (S1)
3	Sense 2, (S2)
4	Current source, (CS)
5	Remote activation, (RA)
6	Indicator output
7	V-
8	Drive output

FIGURE 1. Terminal connections.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A		5962-89780
		REVISION LEVEL	SHEET 7

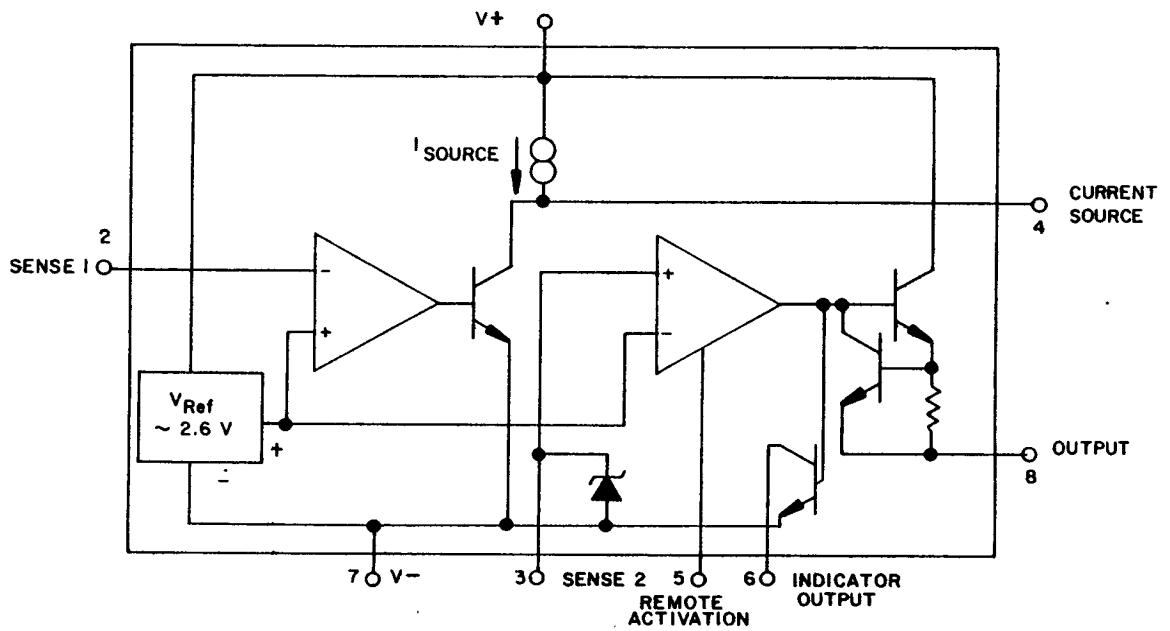


FIGURE 2. Logic diagram.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780	
		REVISION LEVEL	SHEET 8

DESC FORM 193A
SEP 87

★ U. S. GOVERNMENT PRINTING OFFICE: 1986-549-904

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

- a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^\circ\text{C}$, minimum.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

- a. Tests shall be as specified in table II herein.
- b. Subgroups 4, 5, 6, 7, 8, 9, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test conditions, method 1005 of MIL-STD-883:
 - (1) Test condition A using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^\circ\text{C}$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780
		REVISION LEVEL

TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1
Final electrical test parameters (method 5004)	1*, 2, 3
Group A test requirements (method 5005)	1, 2, 3
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

*PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).

6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513) 296-6022.

6.5 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780
	REVISION LEVEL	SHEET 10

查询 5962-8978001PA 供应商

6.6 Approved sources of supply. Approved sources of supply are listed in MIL-BUL-103. Additional sources will be added as they become available. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS. The approved source of supply listed below is for information purposes only and is current only to the date of the last action of this document.

Military drawing part number	Vendor CAGE number	Vendor similar part number ^{1/}
5962-8978001PX	04713	3523/BPAJC

^{1/} Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number

04713

Vendor name and address

Motorola Incorporated
7402 South Price Road
Tempe, AZ 85283

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	5962-89780
	REVISION LEVEL	SHEET 11

DESC FORM 193A
SEP 87

★ U. S. GOVERNMENT PRINTING OFFICE: 1988-549-904